

CUSTOM ATE PROBE CARD

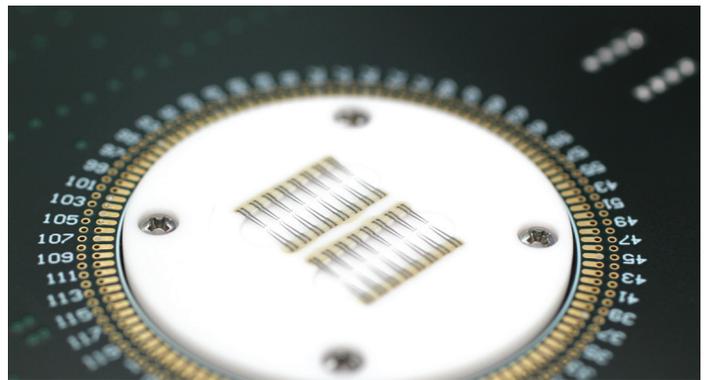
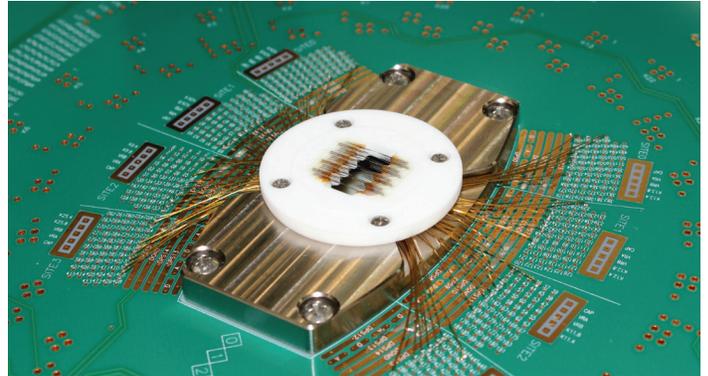
CELADON TILE-ON-CARD™

Production Multiprobe – Extreme Temperature options available

Imagine the ability to test 4/8/16 DUTs at once at 200C for Automotive production test or multiple DUTs at 4K for Quantum Computing testing

What you can expect:

- Increased throughput, exceptional probe card lifetime performance coupled with stability over Extreme Temperatures, Celadon's TOC™ probe card leads the industry in performance and cost.
- Celadon's uniquely robust and repairable patented probe-in-ceramic crash resistant probe cards reduce maintenance headaches while increasing tester utilization. Celadon's TOC™ probe cards are known for achieving 10 Million+ touch downs before rebuild on test floors worldwide.
- In addition to Semiconductor applications, Celadon's TOC™s probe cards are chosen for production in Medical, Military and Space applications worldwide.
- Celadon can design a PCB for a custom application, or even convert an existing epoxy ring card into a Celadon Tile-on-Card™.
- With PCB materials and low-leakage expertise, Celadon can design a solution to fit any requirement.
- The end result to expect with this product is low cost of test with superior test capability.



CELADON'S PATENTED CRASH RESISTANT PROBES IN A CUSTOM ATE PROBE CARD

